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Application Number	09/526,091	
Filing Date	March 15, 2000	
First Named Inventor	Michael L. Wach	
Group Art Unit	2874	•
Examiner Name	Lee, J.	
Attorney Docket Number	06948 105009	

FOREIGN PATENT DOCUMENTS						
Examiner	Cite	Foreign Patent Document	Date of Publication	_	Pages, Columns, Lines, Where	
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ADI	AF	WO	00/72491	A2	30/11/2000	PCT	,	

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PTO/SB/08A (08-00)
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Examiner Initials *	Cite No. 1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>6</sup>
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